## Notice of References Cited Examiner Art Unit

Reexamination 10/598,422 DENG ET AL.

KUO WOO 2617 Page 1 of 1

Applicant(s)/Patent Under

## U.S. PATENT DOCUMENTS

Application/Control No.

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
*	В	US-2005/0195099 A1	09-2005	Vidal, Alberto	341/176
	υ	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	н	US-		-	
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	v					
	w					
	x					

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.